

# Test Report

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## RF test report

090251-AU01+W01



**SCM Microsystems Pvt. Ltd.**

RFID stick  
SCL3711



The test result refers exclusively  
to the model tested.

This report must not be copied without  
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Revision: 2.0



Registration number: DAT-P-224/95-02

# EMV **TESTHAUS** GmbH

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## Accreditation:



Registration number: DAT-P-224/95-02  
CAB (EMC) registration number: BNetzA-CAB-02/21-02/1  
FCC facility registration number: 221458  
Industry Canada registration number: 3472A-1

## Place of Inspection:

EMV **TESTHAUS** GmbH  
Gustav-Hertz-Straße 35  
94315 Straubing  
Germany

The technical accuracy is guaranteed through the quality management of the  
EMV **TESTHAUS** GmbH



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# 1 Test regulations

CFR 47 Part 2: 10-2008	Code of Federal Regulations Part 2 (Frequency allocation and radio treaty matters; General rules and regulations) of the Federal Communication Commission (FCC)
CFR 47 Part 15: 10-2008	Code of Federal Regulations Part 15 (Radio Frequency Devices) of the Federal Communication Commission (FCC)
ANSI C63.4: December 2003	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz



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## 2 Summary of test results

### FCC CFR 47 Part 2 and Part 15

Section	Test	Page	Result
2.1046(a)	Conducted output power	----	Not applicable
2.202(a)	Occupied bandwidth	32	Recorded
15.215(c)	Occupied bandwidth	35	Passed
2.201, 2.202	Class of emission	52	Calculated
15.35(c)	Pulse train measurement	----	Not applicable
15.205(a) 15.205(d)(7)	Restricted bands of operation	----	Passed
15.207	Conducted emission at AC power line 0,150MHz to 30MHz	14	Passed
15.225(a)-(d)	Spectrum mask	10	Passed
15.205(b) 15.215(b) 15.225(a)(d)	Radiated emission 0,009MHz to 30MHz	21	Passed
15.205(b) 15.225(d)	Radiated emission 30MHz to 1000MHz	26	Passed
15.225(e)	Carrier frequency stability	39	Passed



### 3 Equipment under Test (EUT)

Device name: RFID stick SCL3711

Manufacturer: SCM Microsystems (India) Pvt. Ltd.

Serial number: 21120908G00292 (Sample 3)

FCC ID: MBPSCL3711-0200

Application freq. band: 13.110MHz – 14.010MHz

Frequency range: 13.1466 MHz – 13.8906 MHz

Operating frequency: 13.56023 MHz

Class of emission: 10K0A1D

Type of modulation: ASK

Channel spacing: N/A

Number of RF-channels: 1

Pulse train: none

Pulse width: none

Antenna type: Integrated PCB antenna  
 detachable       not detachable

Power supply: USB powered  
nominal: 5.0 V  
minimum: 4.50 V  
maximum: 5.50 V

Temperature range: -20 °C to +55 °C

Interfaces: N/A



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### 3.1 Photo documentation



Picture 1: EUT front



Picture 2: EUT back



## 3.2 Short description of the EUT

The EUT is a RFID Reader with the operating frequency of 13.56 MHz

## 3.3 Operation Mode

The EUT was tested in the following operation modes:

- Reading tags continuously. For this mode a software form SCM was used.

## 3.4 Configuration

The following peripheral devices and interface cables were connected during the tests:

Device	Model:	S/N
RFID Reader (EUT)	SCL3711	21120908G00292
USB Cable *	Standard cable form SCM 1.5m	N/A
Test Notebook	Pro 600 IW	N/A

\* The USB cable was only used to power and configure the EUT during RF tests and is not included in the final product package.



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# 4 Spectrum Mask

according to CFR 47 Part 15, section 15.225 (a)-(d)

## 4.1 Test location

- Scan with peak detector in 3 m CDC
- CISPR measurement with quasi peak detector on 10m open area test site.
- Measurement with peak detector on 3m open area test site

Description	Manufacturer	Inventory No.
CDC	Albatross Projects	100089
Open area test site	EMV <b>TESTHAUS</b> GmbH	200017

## 4.2 Test Instruments

	Description	Manufacturer	Inventory No.
<input type="checkbox"/>	ESCS 30 (FF)	Rohde & Schwarz	100072
<input checked="" type="checkbox"/>	ESCI (CDC)	Rohde & Schwarz	100132
<input checked="" type="checkbox"/>	HFH2-Z2	Rohde & Schwarz	100005
<input type="checkbox"/>	VULB 9163 (CDC)	Schwarzbeck	100077
<input type="checkbox"/>	VULB 9160 (FF)	Schwarzbeck	100064



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### 4.3 Limits

Frequency [MHz]	Field strength Fs [ $\mu\text{V/m}$ ]	Field strength [dB $\mu\text{V/m}$ ]	Measurement distance d [m]
1.705 – 13.110	30	29.5	30
13.110 -13.410	106	40.5	30
13.410 – 13.553	334	50.5	30
13.553 – 13.567	15848	84.0	30
13.567 – 13.710	334	50.5	30
13.710 – 14.010	106	40.5	30
14.010 – 30.000	30	29.5	30

To calculate the limit for 3m measurement distance the following calculation was used.

$$L_{dm} = L_d + (-40 \frac{dB}{dec} * (\log(dm) - \log(d)) - 20$$

$L_{dm}$  = Limit at the new distance  
 $L_d$  = Limit according ANSI 63.4  
 $dm$  = Distance according to ANSI 63.4  
 $d$  = New distance for limit

$$L_{dm} = 29,5 \frac{dB\mu V}{m} + (-40 \frac{dB}{dec} * (\log(3m) - \log(30m)) - 20 = 49,5dB$$

$$L_{dm} = 40,5 \frac{dB\mu V}{m} + (-40 \frac{dB}{dec} * (\log(3m) - \log(30m)) - 20 = 60,5dB$$

$$L_{dm} = 50,5 \frac{dB\mu V}{m} + (-40 \frac{dB}{dec} * (\log(3m) - \log(30m)) - 20 = 70,5dB$$

$$L_{dm} = 84 \frac{dB\mu V}{m} + (-40 \frac{dB}{dec} * (\log(3m) - \log(30m)) - 20 = 104dB$$



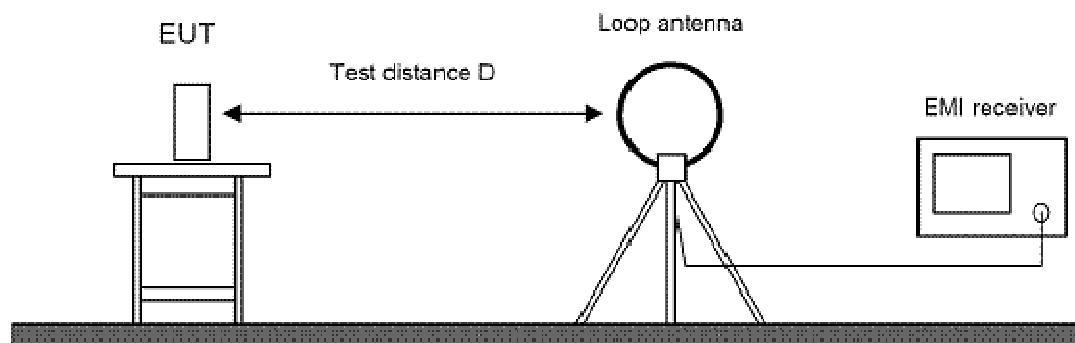
## 4.4 Test method to demonstrate compliance

A spectrum analyzer was used and set to a center frequency equal to transmitter frequency. The resolution bandwidth was adjusted to 3 kHz and the video bandwidth at least 3 times higher than the resolution bandwidth. Span was set to 1 MHz to cover the whole spectrum mask. The detector was set to maxpeak with hold function.

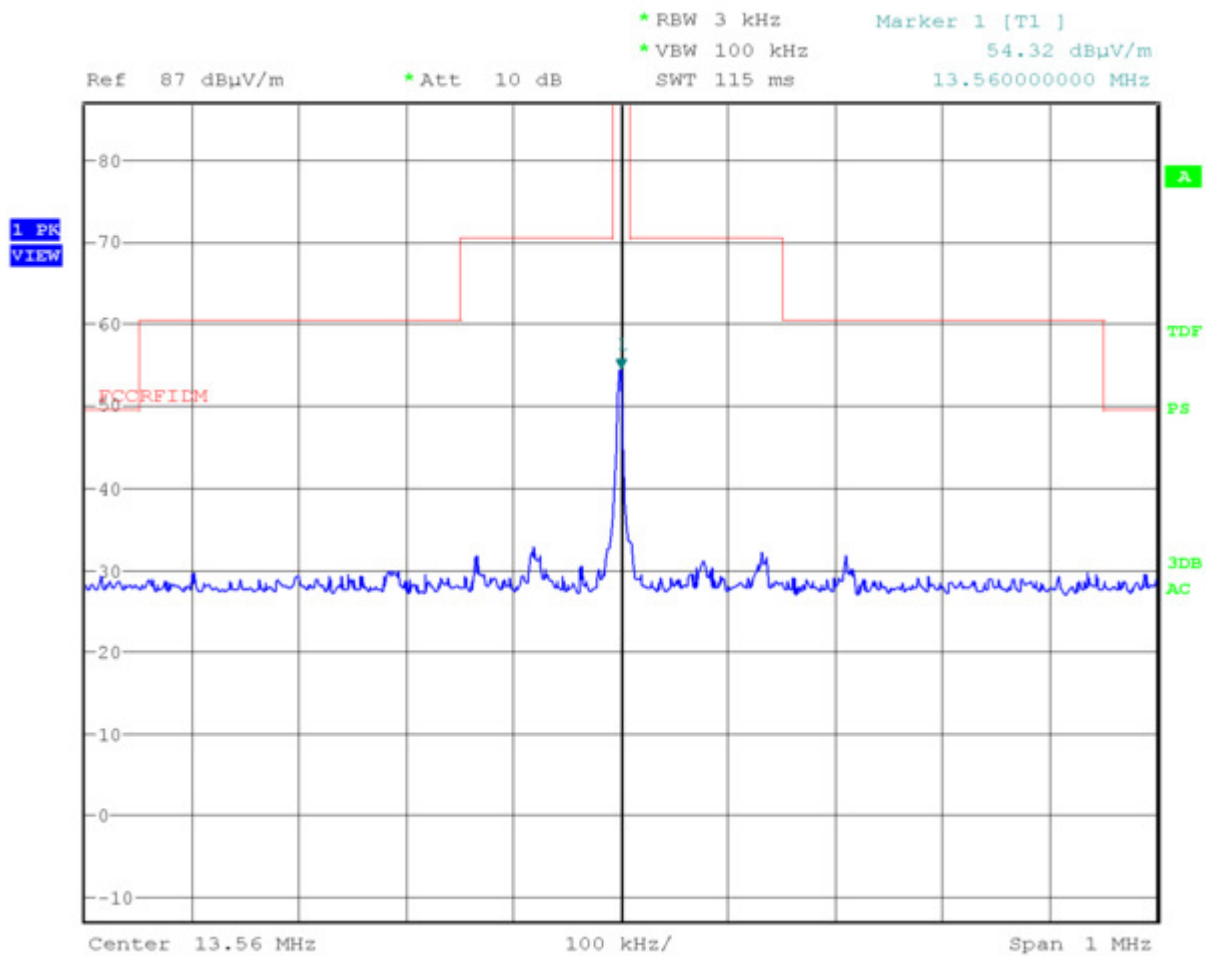
The spectrum analyzer was connected to a loop antenna with vertical polarization at a measurement distance of 3 m on an open area test site. This loop antenna has a correction factor of 20 dB. Due to better visibility in the printing the actual spectrum mask limit was reduced by this 20 dB. Therefore the Picture 4 shows the correct distance to the limit. To get the correct field strength 20 dB has to be added to the marker value T1.

The EUT was placed on a turntable and rotate 360° to find maximum value. To find the maximum in horizontal polarization the EUT was rotated by 90°.

## 4.5 Test setup



Picture 3: Outline of setup for spectrum mask test



**Picture 4: Result of spectrum mask measurement**

The actual field strength of the carrier is:

$$FS = T1 + 20 \text{ dB} = 54.32 \text{ dB}\mu\text{V/m} + 20 \text{ dB} = 74.32 \text{ dB}\mu\text{V/m}$$

Expanded uncertainty (0,009 to 30MHz):

$$E_{(y)} = (y \pm 4,25) \text{ dB}\mu\text{A/m}; k=2.00$$

y = Indicated value

Comments:

# 5 Conducted emission test

according to CFR 47 Part 15, section 15.207

## 5.1 Test Location

Description	Manufacturer	Inventory No.
Shielded chamber	Siemens - Matsushita	200016

## 5.2 Test Instruments

	Description	Manufacturer	Inventory No.
<input checked="" type="checkbox"/>	ESH 3	Rohde & Schwarz	100002
<input type="checkbox"/>	ESCS 30	Rohde & Schwarz	100072
<input type="checkbox"/>	ESCI	Rohde & Schwarz	100132
<input checked="" type="checkbox"/>	ESH3 Z2	Rohde & Schwarz	200051
<input checked="" type="checkbox"/>	ESH 2-Z5	Rohde & Schwarz	100040



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## 5.3 Limits

Frequency [MHz]	Quasi-peak [dB $\mu$ V]	Average [dB $\mu$ V]
0.15 – 0.5	66 - 56	56 – 46
0.5 – 5.0	56	46
5 – 30	60	50

## 5.4 Test method to demonstrate compliance

The tests of conducted emission were carried out in a shielded room using a line impedance stabilization network (LISN) 50  $\mu$ H/50 Ohms and an EMI test receiver. The EMI test receiver was connected to the LISN and set to a measurement bandwidth of 9 kHz in the frequency range from 0.15 MHz to 30 MHz.

The EUT was placed on a wooden table and connected to the LISN.

To accelerate the measurement the detector of the EMI test receiver was set to peak and the whole frequency range from 0.15 MHz to 30 MHz were scanned. After that all peaks values with fewer margins than 10 dB to quasi-peak limit or exceeding the limit were marked and re-measured with quasi-peak detector. If after that all values are under the average limit no addition measurement is necessary. In case there are still values between quasi-peak and average limit than these values were re-measured again with an average detector.

These measurements were done on all current carrying conductors.

According to ANSI C63.4, section 13.1.3.1 testing of intentional radiators with detachable antennas shall be done with a dummy load otherwise the tests should be done with connected antenna and if adjustable fully extended.



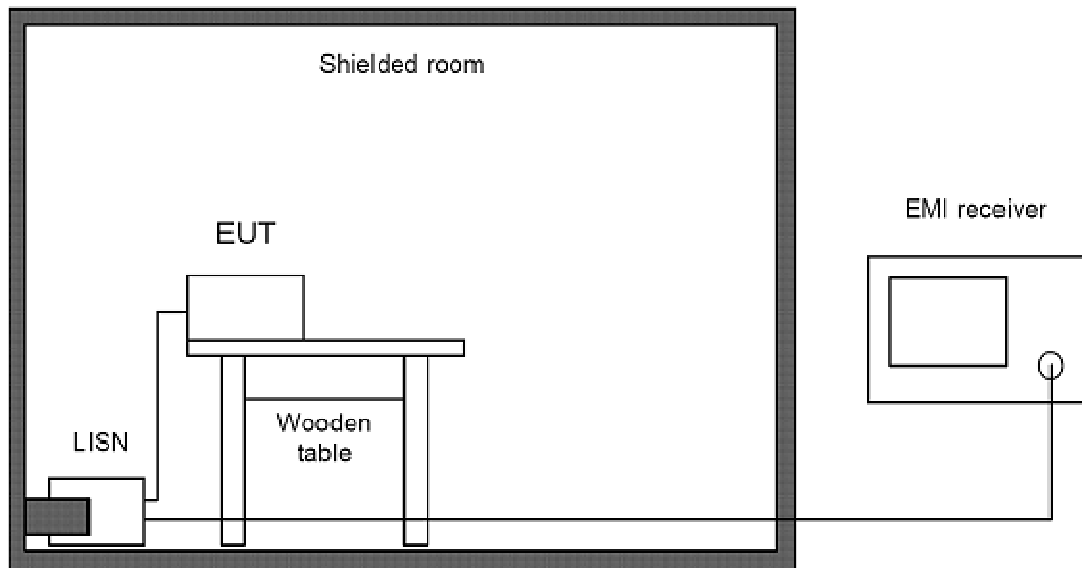
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## 5.5 Test setup



**Picture 5: Outline of conducted emission test setup**

Expanded Uncertainty (9kHz to 150kHz):

$$U_{(y)} = (y \pm 4.024) \text{ dB}\mu\text{V}; k=2.00$$

y = Indicated value

Expanded Uncertainty (150kHz to 30MHz):

$$U_{(y)} = (y \pm 3.604) \text{ dB}\mu\text{V}; k=2.00$$

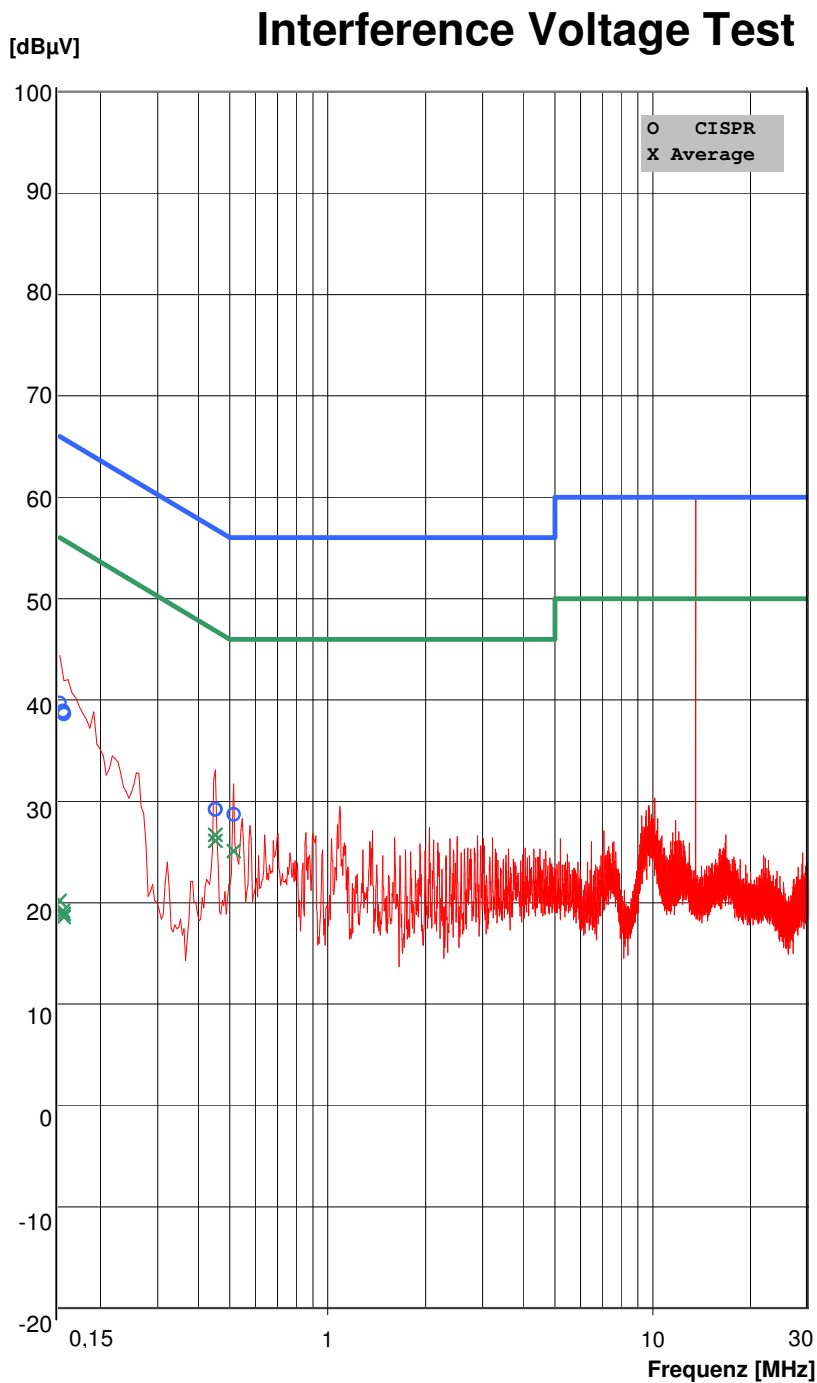
y = Indicated value

Comments: The 13.56 MHz disturbance belongs to the carrier frequency, which is exempted for this test. Due to a fixed internal antenna a test with 50 Ohm dummy was not possible.

All peripheral devices were additionally decoupled by means of a line stabilization network.



## 5.6 Test result



#### REGULATIONS:

CISPR 22  
PEAK / CISPR / AV

#### TEST EQUIPMENT:

R&S ESH3 (10 0 002)  
R&S ESH2-Z5 (10 0 040)  
R&S Pulse Limiter (20 0 051)

#### ORDER NO.:

090251-AU01+W01

#### EUT:

SCM Microsystems (India) Pvt.  
Ltd.  
RFID Product  
SCL3711  
21120908G00289

#### OPERATION MODE:

transmission active  
EUT connected to a notebook  
test software from SCM  
Mains 120 V AC / 60Hz  
Phase

#### TEST FACILITY:

EMV TESTHAUS GmbH  
Gustav-Hertz-Straße 35  
94315 Straubing

#### DATE / TIME:

2009-04-29  
19 °C 56 %H 97 kPa

#### TEST ENGINEER:

Marco Janker

090251 ss L1 USB 01 no 13MHz.E10

Picture 6: Conducted emission on mains, phase 1



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## Interference Voltage Test

Freq. [MHz]	U_CISPR [dBµV]	Limit [dBµV]	delta_U [dB]	U_AV [dBµV]	Limit [dBµV]	delta_U [dB]	Corr. [dB]	Remark
0,15	39,7	66,0	26,3	20,2	56,0	35,8	0,0	090251 ss L1 USB 01 no 13MHz.E10
0,15	38,6	65,8	27,2	18,6	55,8	37,2	0,0	
0,15	38,7	65,8	27,1	18,9	55,8	36,9	0,0	
0,15	38,9	65,8	26,9	19,2	55,8	36,6	0,0	
0,45	29,2	56,8	27,6	26,1	46,8	20,7	0,0	
0,45	29,2	56,8	27,6	26,7	46,8	20,1	0,0	
0,51	28,7	56,0	27,3	25,1	46,0	20,9	0,0	

**Picture 7: Conducted emission on mains, phase 1**



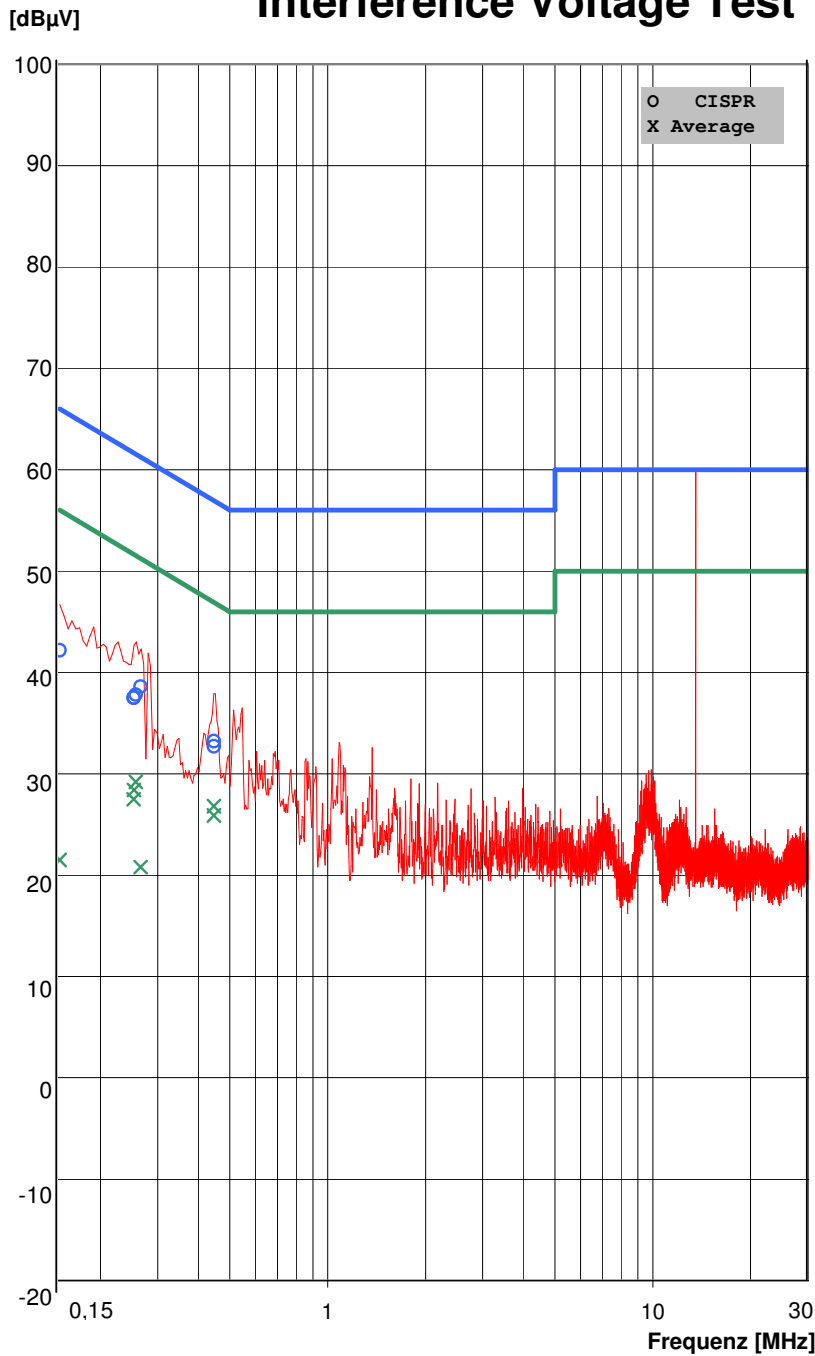
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# Interference Voltage Test



## REGULATIONS:

CISPR 22  
PEAK / CISPR / AV

## TEST EQUIPMENT:

R&S ESH3 (10 0 002)  
R&S ESH2-Z5 (10 0 040)  
R&S Pulse Limiter (20 0 051)

## ORDER NO.:

090251-AU01+W01

## EUT:

SCM Microsystems (India) Pvt.  
Ltd.  
RFID Product  
SCL3711  
21120908G00289

## OPERATION MODE:

transmission active  
EUT connected to a notebook  
test software from SCM  
Mains 120 V AC / 60Hz  
Neutral

## TEST FACILITY:

EMV TESTHAUS GmbH  
Gustav-Hertz-Straße 35  
94315 Straubing

## DATE / TIME:

2009-04-29  
19 °C 56 %H 97 kPa

## TEST ENGINEER:

Marco Janker

090251 ss N USB 01 no 13MHz.E10

Picture 8: Conducted emission on mains, neutral



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## Interference Voltage Test

Freq. [MHz]	U_CISPR [dBµV]	Limit [dBµV]	delta_U [dB]	U_AV [dBµV]	Limit [dBµV]	delta_U [dB]	Corr. [dB]	Remark
0,15	42,2	66,0	23,8	21,5	56,0	34,5	0,0	090251 ss N USB 01 no 13MHz.E10
0,25	37,5	61,6	24,1	28,4	51,6	23,2	0,0	
0,25	37,5	61,7	24,2	27,5	51,7	24,2	0,0	
0,26	37,8	61,5	23,7	29,2	51,5	22,3	0,0	
0,27	38,6	61,3	22,7	20,8	51,3	30,5	0,0	
0,45	33,2	56,9	23,7	26,8	46,9	20,1	0,0	
0,45	32,7	56,9	24,2	25,9	46,9	21,0	0,0	

**Picture 9: Conducted emission on mains, neutral**



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# 6 Measurement of radiated emission

according to CFR 47 Part 15, section 15.205(d7), 15.209

## 6.1 Radiated emission measurement from 9 kHz to 30 MHz:

### 6.1.1 Location of measurement

- Scan with peak detector in 3 m CDC
- Final CISPR measurement with quasi peak detector on 3m open site area.

Description	Manufacturer	Inventory No.
CDC	Albatross Projects	100089
Open site area	EMV <b>TESTHAUS</b> GmbH	200017

### 6.1.2 Measurement equipment

	Description	Manufacturer	Inventory No.
<input type="checkbox"/>	ESCS 30 (FF)	Rohde & Schwarz	100072
<input checked="" type="checkbox"/>	ESU (CDC)	Rohde & Schwarz	100146
<input type="checkbox"/>	ESCI (CDC and FF)	Rohde & Schwarz	100132
<input type="checkbox"/>	VULB 9163 (CDC)	Schwarzbeck	100077
<input type="checkbox"/>	VULB 9160 (FF)	Schwarzbeck	100064
<input checked="" type="checkbox"/>	Feedline OATS	Huber & Suhner	200024
<input checked="" type="checkbox"/>	HFH2-Z2 (CDC and FF)	Rohde & Schwarz	100005



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### 6.1.3 Limits

Frequency [MHz]	Field strength Fs [ $\mu\text{V/m}$ ]	Field strength [dB $\mu\text{V/m}$ ]	Measurement distance d [m]
0.009 – 0.490	266.7 – 4.9	48.5 – 13.8	300
0.490 – 1.705	49.0 – 14.1	33.8 – 23.0	30
1.705 - 30	30	29.5	30

To calculate the limit for 3m measurement distance the following calculation was used.

$$L_{dm} = L_d + \left(-40 \frac{dB}{dec}\right) * (\log(dm) - \log(d)) \quad L_{dm} = \text{Limit at the new distance}$$

$L_d$  = Limit according ANSI 63.4  
 $dm$  = Distance according to ANSI 63.4  
 $d$  = New distance for limit

$$L_{dm} = 48.5 \frac{dB\mu V}{m} + \left(-40 \frac{dB}{dec}\right) * (\log(3m) - \log(300m)) = 128,5dB \quad \text{for 0.009MHz}$$

$$L_{dm} = 13.8 \frac{dB\mu V}{m} + \left(-40 \frac{dB}{dec}\right) * (\log(3m) - \log(300m)) = 93.8dB \quad \text{for 0.490MHz (high)}$$

$$L_{dm} = 33.8 \frac{dB\mu V}{m} + \left(-40 \frac{dB}{dec}\right) * (\log(3m) - \log(30m)) = 73.8dB \quad \text{for 0.490MHz (low)}$$

$$L_{dm} = 23 \frac{dB\mu V}{m} + \left(-40 \frac{dB}{dec}\right) * (\log(3m) - \log(30m)) = 63dB \quad \text{for 1.705MHz (high)}$$

$$L_{dm} = 29.5 \frac{dB\mu V}{m} + \left(-40 \frac{dB}{dec}\right) * (\log(3m) - \log(30m)) = 69.5dB \quad \text{for 1.705MHz (low)}$$



## 6.1.4 Test method to demonstrate compliance

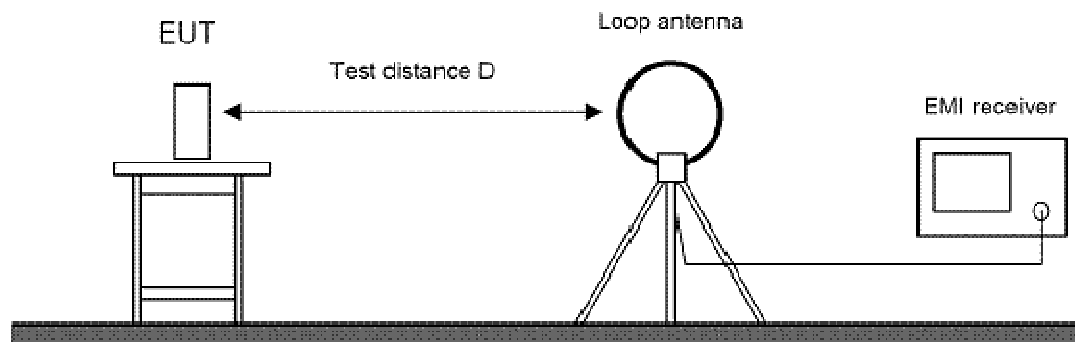
An EMI test receiver was used and connected to the loop antenna. The EUT was placed on a wooden table in a distance of 3m inside a compact diagnostic chamber.. The loop antenna was placed in vertical polarization at an angle of 0° and the EMI receiver performed a scan from 0.009 MHz to 30 MHz with the detector set to peak and the measurement bandwidth to 200 Hz. At .150 kHz the measurement bandwidth was changed to 9 kHz.

This procedure was repeated at 6 different positions of the EUT by rotating turn table. All peak values over the limit or with less distance to limit then 6dB were marked and re-measured with a quasi-peak detector with the following method on a 3m open area test site.

The turn table was turned 360° to find the position of maximum field strength. After reaching this position the loop antenna was rotated 360° to find the maxima. The measured value was recorded. This measurement was done for all marked frequencies with respect to the appropriate bandwidth for the frequency ranges.

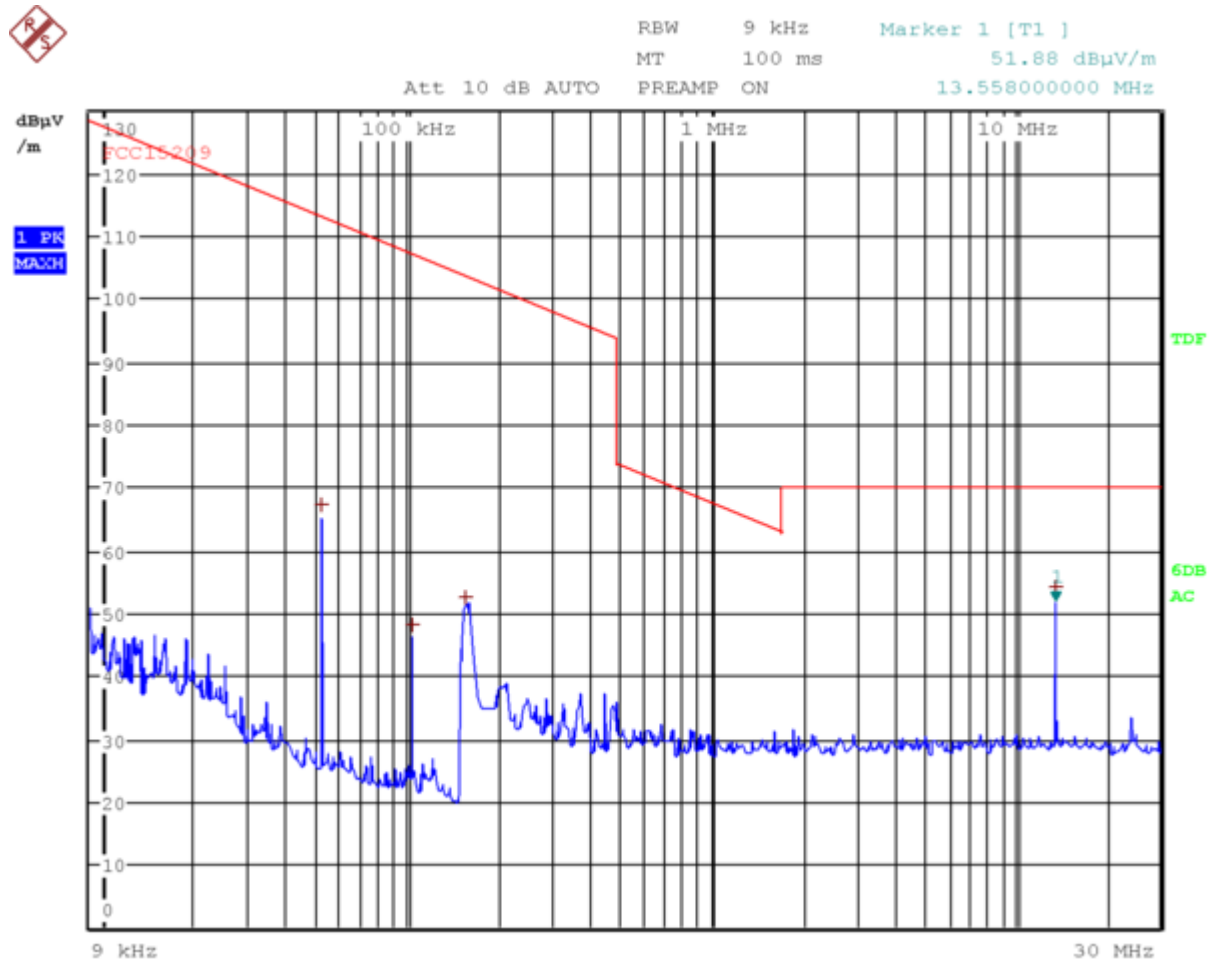
To check the horizontal polarization the EUT was rotated by 90° instead of the loop antenna and the procedure was repeated. Both results are combined inside on graphic.

## 6.1.5 Test setup



Picture 10: Outline of radiated emission test setup

## 6.1.6 Test result



Picture 11: Radiated field strength from 9 kHz to 30 MHz

Frequency	Field strength	Margin
52.040 kHz	67.206894 dBµV/m	-46.147384 dB
104.040 kHz	48.308891 dBµV/m	-59.066094 dB
158.000 kHz	52.623253 dBµV/m	-51.145496 dB
13.558000 MHz	54.176994 dBµV/m	-15.823006 dB

Table 1: Result table of radiated field strength from 9 kHz to 30 MHz



Expanded Uncertainty (9kHz to 150kHz):

$$U_{(y)} = (y \pm 4.024) \text{ dB}\mu\text{V}; k=2.00$$

y = Indicated value

Expanded Uncertainty (150kHz to 30MHz):

$$U_{(y)} = (y \pm 3.604) \text{ dB}\mu\text{V}; k=2.00$$

y = Indicated value



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## 6.2 Radiated emission measurement from 30 MHz to 1000 MHz

### 6.2.1 Location of measurement

- Scan with peak detector in 3 m CDC witch is correlated to the 10m open site area.
- Final CISPR measurement with quasi peak detector on 10m open site area.

Description	Manufacturer	Inventory No.
CDC	Albatross Projects	100089
Open site area	EMV <b>TESTHAUS</b> GmbH	200017

### 6.2.2 Measurement equipment

	Description	Manufacturer	Inventory No.
<input checked="" type="checkbox"/>	ESCS 30 (FF)	Rohde & Schwarz	100072
<input checked="" type="checkbox"/>	ESCI (CDC)	Rohde & Schwarz	100132
<input checked="" type="checkbox"/>	VULB 9163 (FF)	Schwarzbeck	100077
<input checked="" type="checkbox"/>	VULB 9160 (CDC)	Schwarzbeck	100064
<input type="checkbox"/>	HFH2-Z2	Rohde & Schwarz	100005
<input checked="" type="checkbox"/>	Feedline OATS	Huber & Suhner	200024



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## 6.2.3 Limits

Frequency [MHz]	Field strength Fs [ $\mu\text{V/m}$ ]	Field strength [dB $\mu\text{V/m}$ ]	Measurement distance d [m]
30 – 88	100	40	3
88 – 216	150	43.5	3
216 - 960	200	46	3
Above 960	500	54	3

To calculate the limit for 10m measurement distance the following calculation was used.

$$L_{dm} = L_d + (-20 \frac{dB}{dec} * (\log(dm) - \log(d)))$$

$L_{dm}$  = Limit at the new distance

$L_d$  = Limit according ANSI 63.4

$d$  = Distance according to ANSI 63.4

$dm$  = New distance for limit

$$L_{dm} = 40 \frac{dB\mu V}{m} + (-20 \frac{dB}{dec} * (\log(10m) - \log(3m))) = 30dB$$

for 30 MHz to 88 MHz

$$L_{dm} = 43,5 \frac{dB\mu V}{m} + (-20 \frac{dB}{dec} * (\log(10m) - \log(3m))) = 33.5dB$$

for 88 MHz to 216 MHz

$$L_{dm} = 46 \frac{dB\mu V}{m} + (-20 \frac{dB}{dec} * (\log(10m) - \log(3m))) = 36dB$$

for 216 MHz to 960 MHz

$$L_{dm} = 54 \frac{dB\mu V}{m} + (-20 \frac{dB}{dec} * (\log(10m) - \log(3m))) = 44dB$$

above 960 MHz



## 6.2.4 Test method to demonstrate compliance

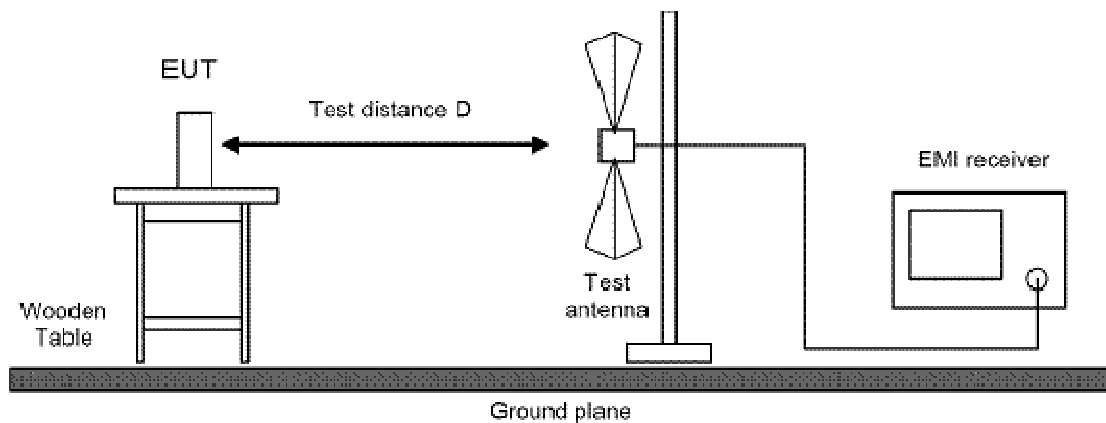
An EMI test receiver was used and connected to a broadband antenna. The EUT was placed on a wooden table in a distance of 3m inside a compact diagnostic chamber. This chamber is a fully anechoic chamber and correlated to our 10m open site. Therefore the 10 m limit was applicable for the pre-scan inside this chamber. The broadband antenna was placed in vertical polarization and the EMI receiver performed a scan from 30 MHz to 1000 MHz with the detector set to peak and the measurement bandwidth to 120 kHz.

This procedure was repeated at 6 different positions of the EUT by rotating turn table. After that die polarization switched to horizontal and repeated this procedure. After all 12 scans the results of the two polarizations were combined.

All peak values over or with less distance to limit then 6 dB were marked and re-measured with a quasi-peak detector with the following method on a 10 m open area test site.

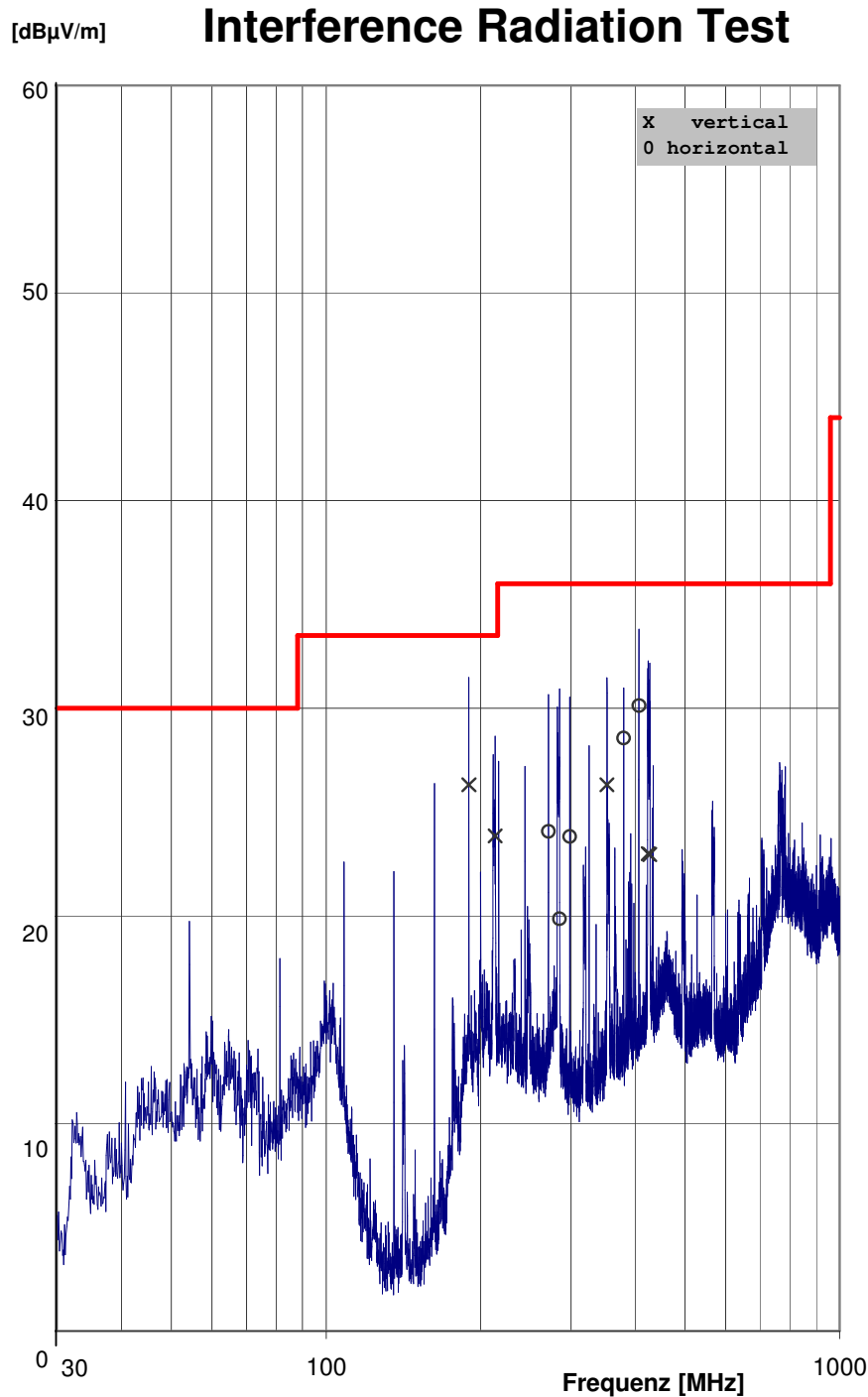
The turn table was turned 360° to find the position of maximum field strength. After reaching this position the antenna was moved form 1 m to 4 m height to find the maximum value. This value was recorded.

## 6.2.5 Test setup



Picture 13: Outline of radiated emission test setup

## 6.2.6 Test result



### REGULATIONS:

FCC 15.209 10m  
PEAK / CISPR

### TEST EQUIPMENT:

R&S ESCS 30 (10 0 072)  
VULB 9160 (10 0 064)  
Suhner (20 0 024)

### ORDER NO.:

090251-AU01+W01

### EUT:

SCM Microsystems (India) Pvt.  
Ltd.  
RFID Product  
SCL3711  
HF sample, Sample 3

### OPERATION MODE:

Continuous transmission  
with customer supplied test tool

### TEST FACILITY:

EMV TESTHAUS GmbH  
Gustav-Hertz-Straße 35  
94315 Straubing

### DATE / TIME:

2009-04-28  
24 °C 40 %H 97 kPa

### TEST ENGINEER:

Marco Janker

090251 FCC radiated emission

Picture 14: Radiated emission 30 MHz – 1000MHz



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## Interference Radiation Test

Freq. [MHz]	U_Rec [dBμV/m]	Limit [dBμV/m]	Corr. [dB]	U_Ant. [dBμV]	delta_U [dB]	Turn- table	Antenna	Pol.	Remark <small>090251 FCC radiated emission</small>
189,80	26,3	33,5	12,3	14,0	7,2	163°	110 cm	V	
213,50	23,9	33,5	12,0	11,9	9,7	290°	110 cm	V	
271,20	24,1	36,0	14,4	9,7	11,9	14°	250 cm	H	
284,70	19,9	36,0	14,9	5,0	16,2	95°	250 cm	H	
298,30	23,8	36,0	15,3	8,6	12,2	183°	250 cm	H	
352,50	26,3	36,0	16,7	9,6	9,7	242°	110 cm	V	
379,70	28,6	36,0	17,5	11,1	7,4	25°	250 cm	H	
406,80	30,1	36,0	18,2	11,9	5,9	0°	250 cm	H	
423,80	23,0	36,0	18,8	4,2	13,0	4°	110 cm	V	
426,80	23,0	36,0	18,9	4,1	13,1	0°	110 cm	V	

**Picture 16: Radiated emission 30 MHz – 1000MHz (Table)**



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Expanded uncertainty (30MHz to 300MHz):

$$E_{(y)} = (y \pm 4.994) \text{ dB}\mu\text{V/m}; k=2.00$$

y = Indicated value

Expanded uncertainty (300MHz to 1000MHz):

$$E_{(y)} = (y \pm 5.276) \text{ dB}\mu\text{V/m}; k=2.00$$

y = Indicated value

Comments:



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# 7 Occupied Bandwidth (99%)

according to CFR 47 Part 2 section 2.202

## 7.1 Test location

Description	Manufacturer	Inventory No.
CDC	Albatross Projects	100089

## 7.2 Test Instruments

	Description	Manufacturer	Inventory No.
<input checked="" type="checkbox"/>	ESCS 30 (FF)	Rohde & Schwarz	100072
<input checked="" type="checkbox"/>	ESCI (CDC)	Rohde & Schwarz	100132
<input checked="" type="checkbox"/>	HFH2-Z2	Rohde & Schwarz	100005
<input type="checkbox"/>	VULB 9163 (CDC)	Schwarzbeck	100077
<input type="checkbox"/>	VULB 9160 (FF)	Schwarzbeck	100064

## 7.3 Test method to demonstrate compliance

The EUT has no detachable antenna therefore the radiated method was used

The occupied bandwidth is measured as the 99% bandwidth. For this measurement the occupied bandwidth function of the spectrum analyzer was used.



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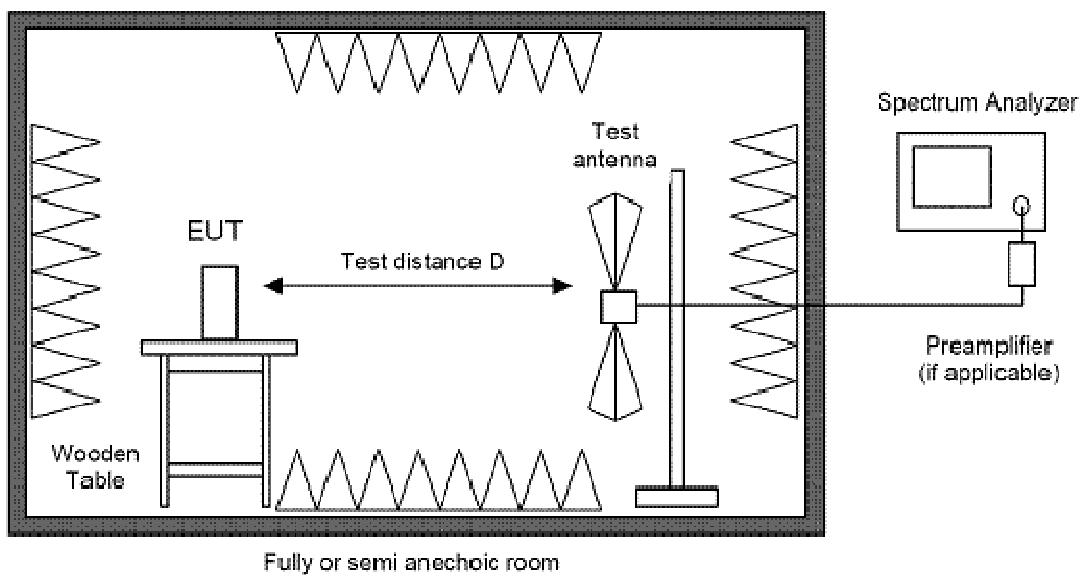
The resolution bandwidth of the spectrum analyzer shall be set to a greater value than 5% of the allowed bandwidth.

Because no resolution bandwidth was given the following guideline from ANSI C63.4 annex H6 was consulted.

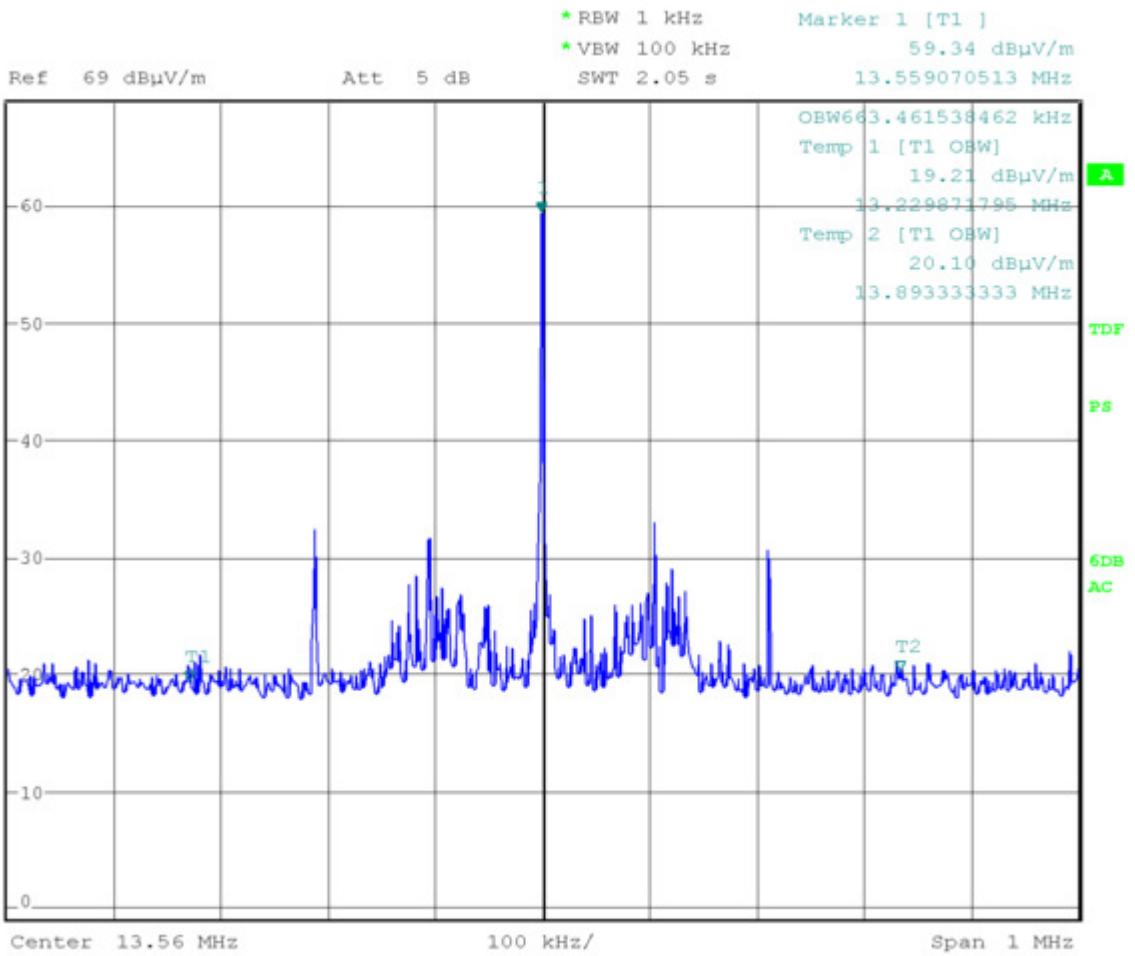
Fundamental frequency	Minimum resolution bandwidth
0.009MHz to 30MHz	1kHz
30MHz to 1000MHz	10kHz
1000MHz to 40000MHz	100kHz

The video bandwidth was adjusted at least 3 times wider than the resolution bandwidth

## 7.4 Test setup



**Picture 17: Outline of test setup for occupied bandwidth measurement**



**Picture 18: Occupied bandwidth 99%**

Frequency lower value:	13.229 MHz	Limit: 13.110 MHz
Frequency upper value:	13.893 MHz	Limit: 14.010 MHz
Occupied Bandwidth:	550 kHz	



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## 8 Occupied Bandwidth (20dB)

according to FCC Part 15, section 15.215(c)

### 8.1 Test location

Description	Manufacturer	Inventory No.
CDC	Albatross Projects	100089

### 8.2 Test Instruments

	Description	Manufacturer	Inventory No.
<input checked="" type="checkbox"/>	ESCS 30 (FF)	Rohde & Schwarz	100072
<input checked="" type="checkbox"/>	ESCI (CDC)	Rohde & Schwarz	100132
<input checked="" type="checkbox"/>	HFH2-Z2	Rohde & Schwarz	100005
<input type="checkbox"/>	VULB 9163 (CDC)	Schwarzbeck	100077
<input type="checkbox"/>	VULB 9160 (FF)	Schwarzbeck	100064

### 8.3 Test method to demonstrate compliance

The EUT has no detachable antenna therefore the radiated method was used

The 20 dB bandwidth of the emission is measured as the frequency range defined by the points that are 20 dB down relative to the maximum level of the modulated carrier. For intentional radiators operating under the alternative provisions to the general emission limits the requirement to contain the 20 dB bandwidth of the emission within the specified frequency band includes the effects from frequency sweeping, frequency hopping and other modulation techniques that may be employed as well as the frequency stability of the transmitter over expected variations in temperature and supply voltage. If a frequency stability is not specified in the regulations, it is recommended that the fundamental emission be kept within at least the central 80% of the permitted band in order to minimize the possibility of out-of-band operation

The resolution bandwidth of the spectrum analyzer shall be set to a greater value than 5% of the allowed bandwidth.



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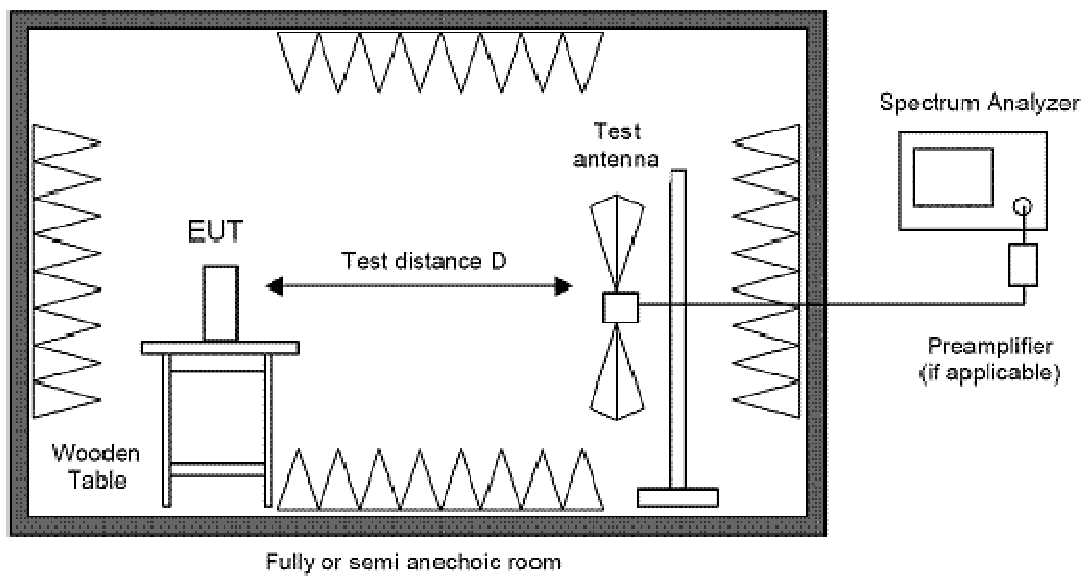
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Because no resolution bandwidth was given the following guideline from ANSI C63.4 annex H6 was consulted.

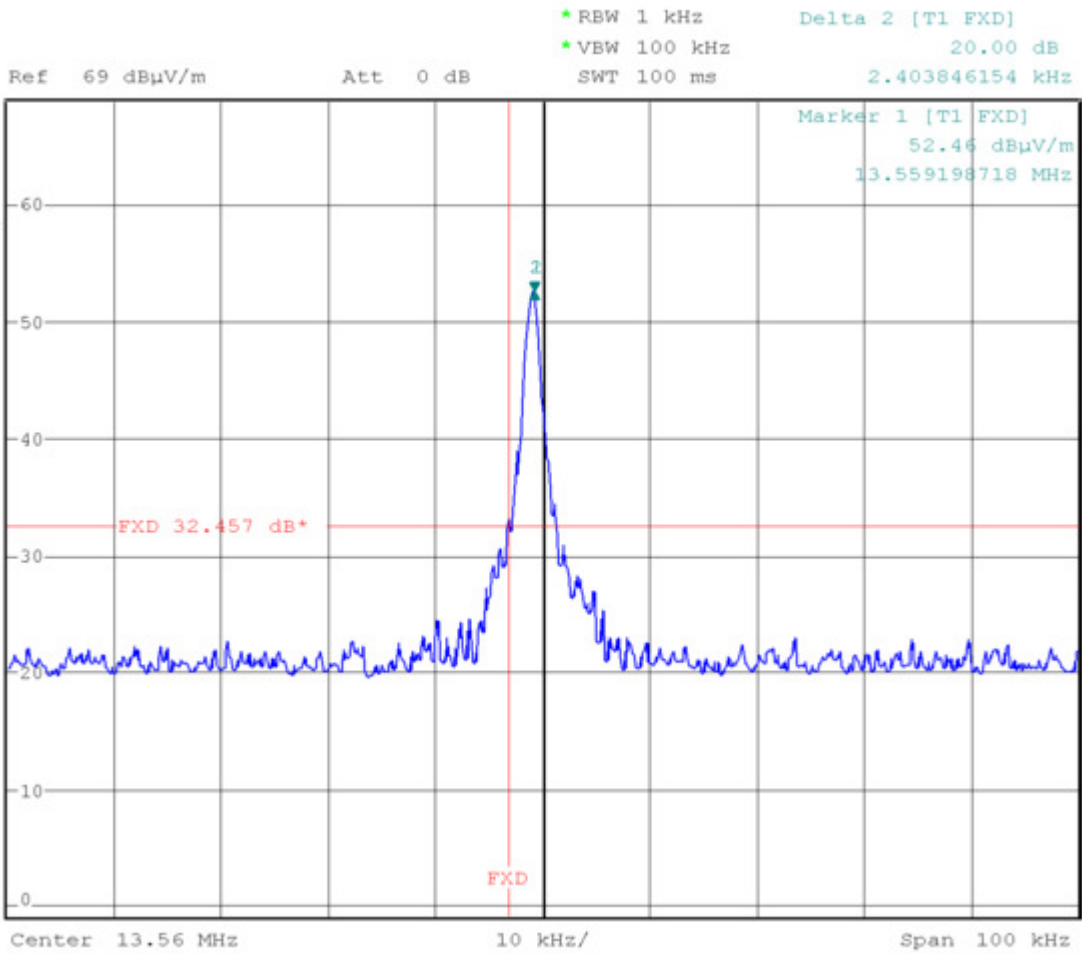
Fundamental frequency	Minimum resolution bandwidth
0.009MHz to 30MHz	1kHz
30MHz to 1000MHz	10kHz
1000MHz to 40000MHz	100kHz

The video bandwidth was adjusted at least 3 times wider than the resolution bandwidth

## 8.4 Test setup



**Picture 19: Outline of occupied bandwidth test setup**



Picture 20: Occupied bandwidth lower value

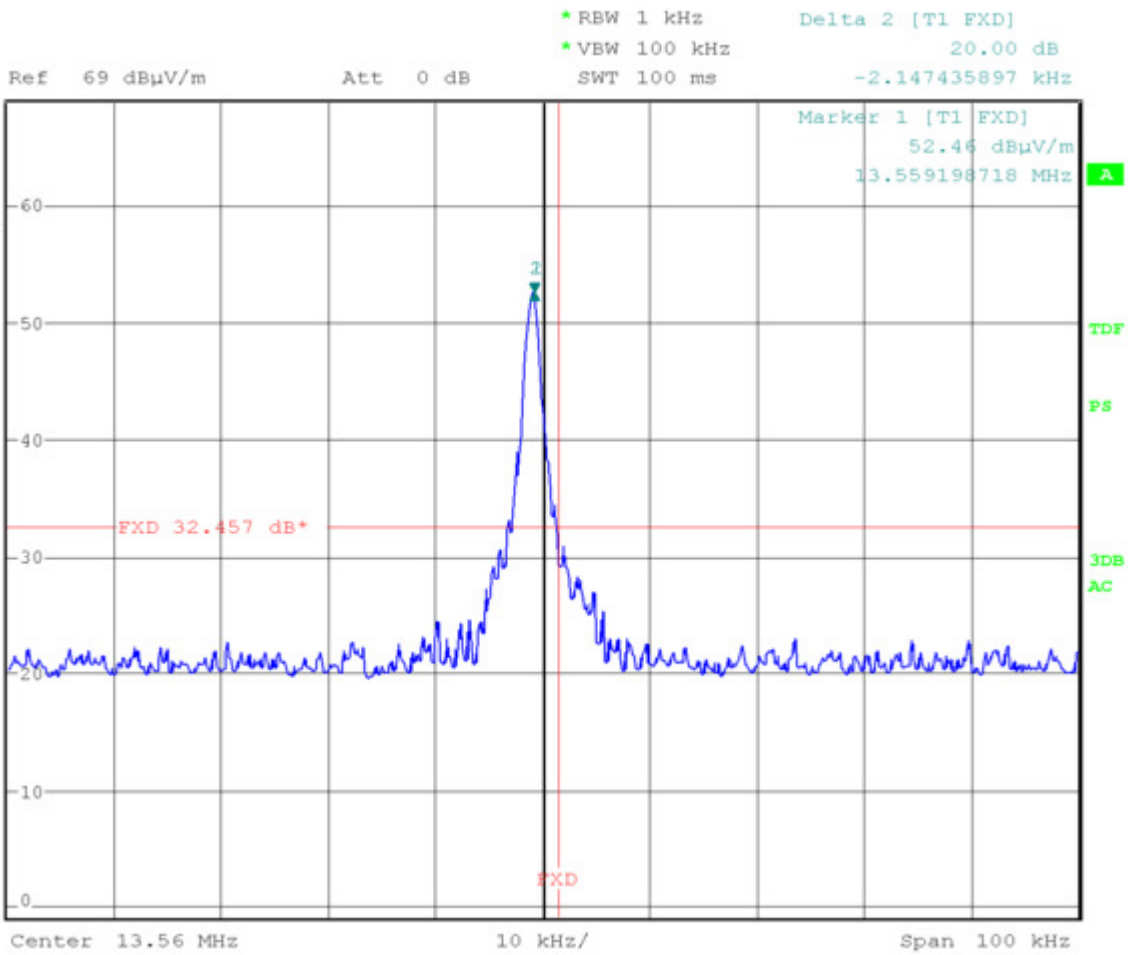


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**Picture 21: Occupied bandwidth upper value**

Frequency lower value:	13.5568 MHz	Limit: 13.110 MHz
Frequency upper value:	13.5571 MHz	Limit: 14.010 MHz
Occupied Bandwidth:	256 Hz	



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## 9 Carrier frequency stability

according to CFR 47 Part 15, section 15.225(e)

### 9.1 Test location

	Description	Manufacturer	Inventory No.
<input checked="" type="checkbox"/>	Climatic Chamber VC4100	Vötsch	110023
<input type="checkbox"/>	Climatic Chamber VC <sup>3</sup> 4043	Vötsch	110040

### 9.2 Test Instruments

	Description	Manufacturer	Inventory No.
<input type="checkbox"/>	ESCI	Rohde & Schwarz	100132
<input checked="" type="checkbox"/>	ESU (CDC)	Rohde & Schwarz	100146
<input checked="" type="checkbox"/>	Test Probe RFR400-1	Langer	200086
<input checked="" type="checkbox"/>	Power Supply	Statron	300193
<input checked="" type="checkbox"/>	Multimeter	Metra Hit 29S	100080
<input type="checkbox"/>	USLP 9142	USLP 9142	100044

### 9.3 Test method to demonstrate compliance

The frequency tolerance of the carrier signal is measured over a temperature variation of -20 °C to +50 °C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 °C. If the EUT provides an antenna connector the spectrum analyzer is connected to this port. If required, a resistive matching network equal to the impedance specified or employed for the antenna is used as well as dc block and appropriate attenuators (50 Ohms). In cases where the EUT does not provide an antenna connector a test fixture is used.

For battery operated equipment, the test is performed using a new battery. Alternatively, an external supply voltage can be used and is at least set to:

- the maximum battery voltage as delivered by a new battery or 115% of the battery nominal voltage
- the battery nominal voltage
- 85% of the battery nominal voltage



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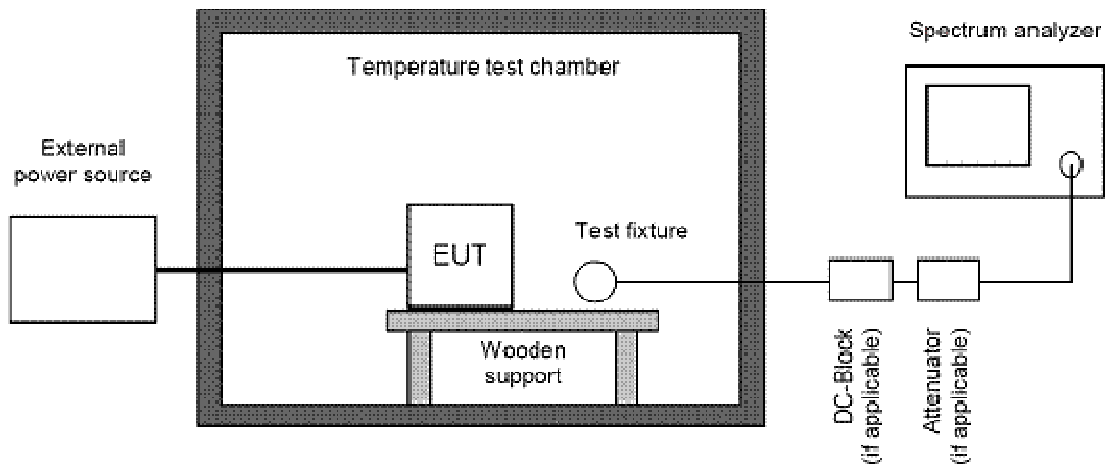
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- the battery operating end point voltage which shall be specified by the equipment manufacturer

The EUT is operating providing an unmodulated carrier. The peak detector of the spectrum analyzer is selected and the resolution bandwidth as well as the video bandwidth is set to values appropriate to the shape of the spectrum of the EUT. The frequency counter mode of the spectrum analyzer is used to maximize the accuracy of the measured frequency tolerance.

If an unmodulated carrier is not available a significant and stable point on the spectrum is selected and the span is reduced to a value that delivers an accuracy which shall be better than 1% of the maximum frequency tolerance allowed for the carrier signal. This method may be performed as long as the margin to the frequency tolerance allowed is larger than the uncertainty of the measured frequency tolerance

## 9.4 Test setup



**Picture 22: Outline of carrier frequency stability test setup**



## 9.5 Carrier vs. temperature

Supply Voltage 5V		Nominal frequency: 13.55908 MHz	
Temperature	Carrier frequency	$\Delta$ Frequency	Deviation
°C	MHz	Hz	Ppm
-20	13.55916	+77	+5.7
-10	13.55916	+76	+5.6
0	13.55913	+48	+3.5
+10	13.55912	+38	+2.8
+20	13.55908	0	0
+30	13.55908	+5	+0.4
+40	13.55907	-14	-1.0
+50	13.55908	-5	-0.4
Limit $\pm$ 100ppm			

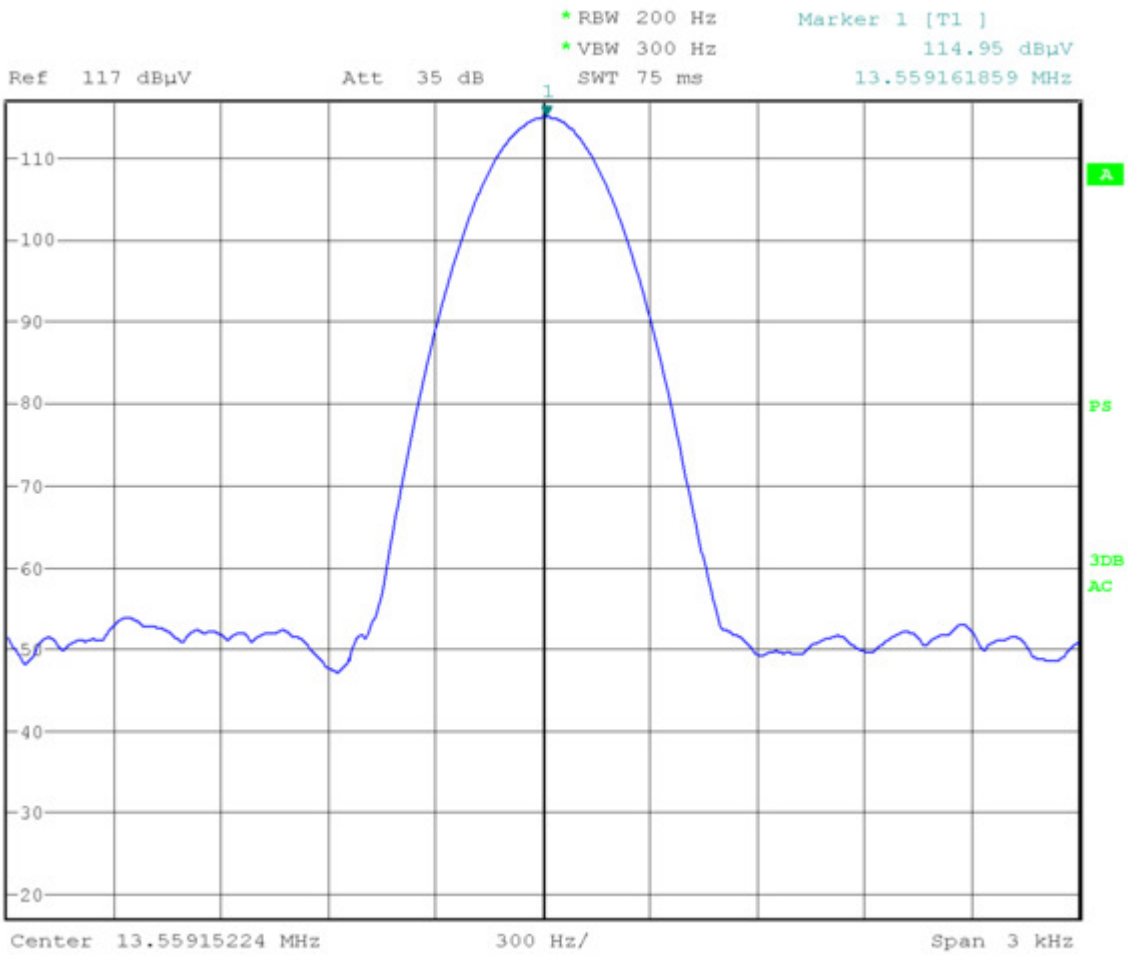
**Table 2: Carrier vs. temperature**

## 9.6 Carrier vs. input voltage

Temperature 20 °C		Nominal frequency: 13.55908 MHz	
Voltage	Carrier frequency	$\Delta$ Frequency	Deviation
V	MHz	Hz	ppm
4,25	13.55908	-5	-0.4
5V	13.55908	0	0
5,75	13.55908	-5	-0.4
Limit $\pm$ 100ppm			

**Table 3: Carrier vs. input voltage**





Picture 23: -20 °C, 5 VDC



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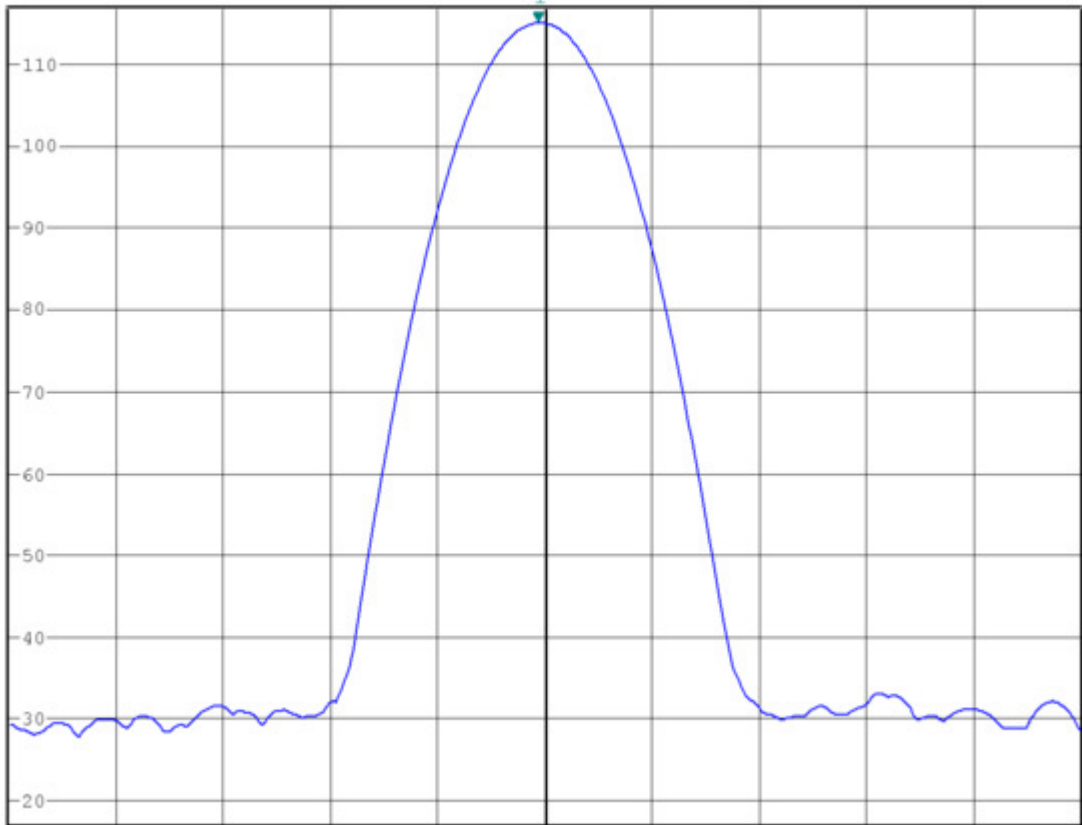


\* RBW 200 Hz      Marker 1 [T1 ]  
\* VBW 300 Hz      114.99 dBµV  
SWT 75 ms      13.559133013 MHz

Ref 117 dBµV

Att 35 dB

1 PK  
VIEW



Center 100 MHz

300 Hz/

Span 3 kHz

Picture 25: 0°C, 5 VDC

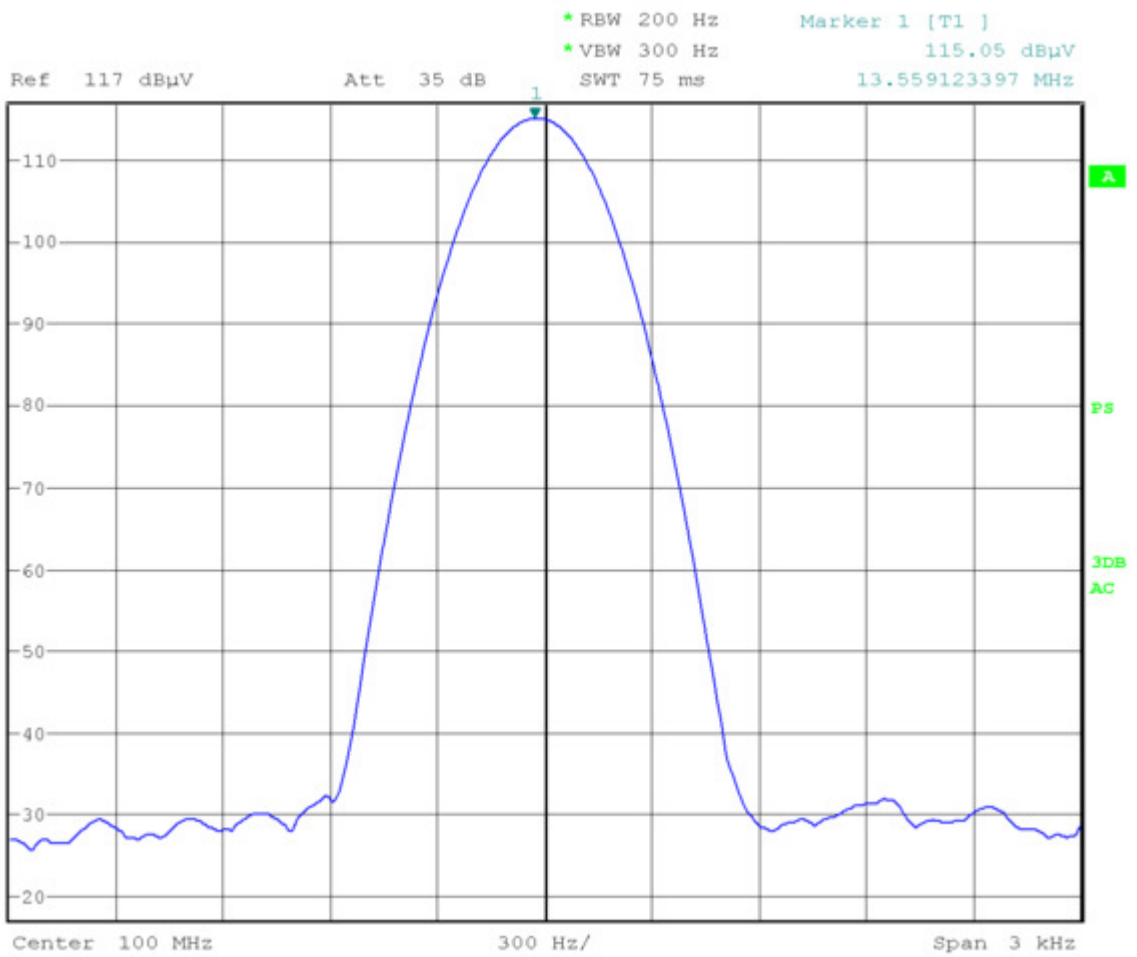


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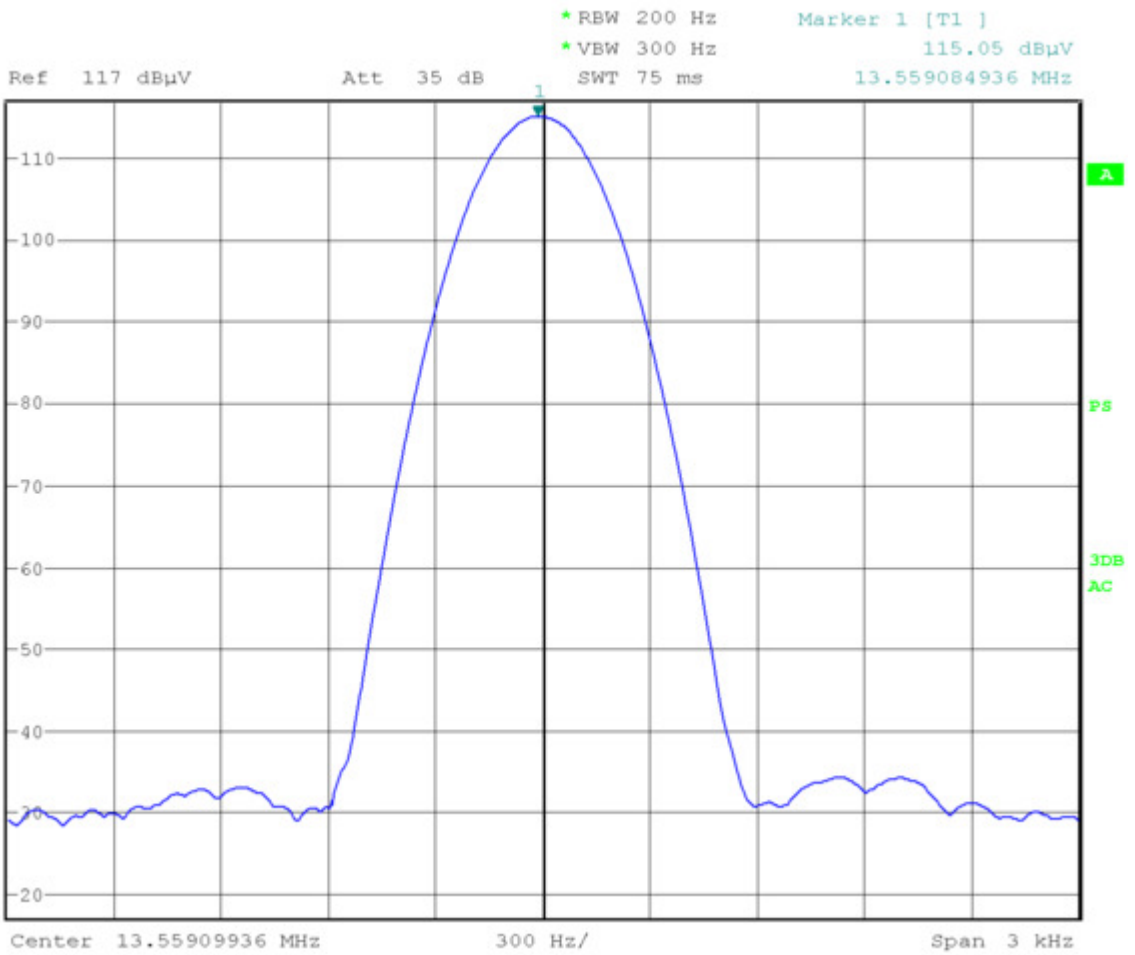


Picture 26: +10°C, 5 VDC



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Picture 27: +20°C, 5 VDC

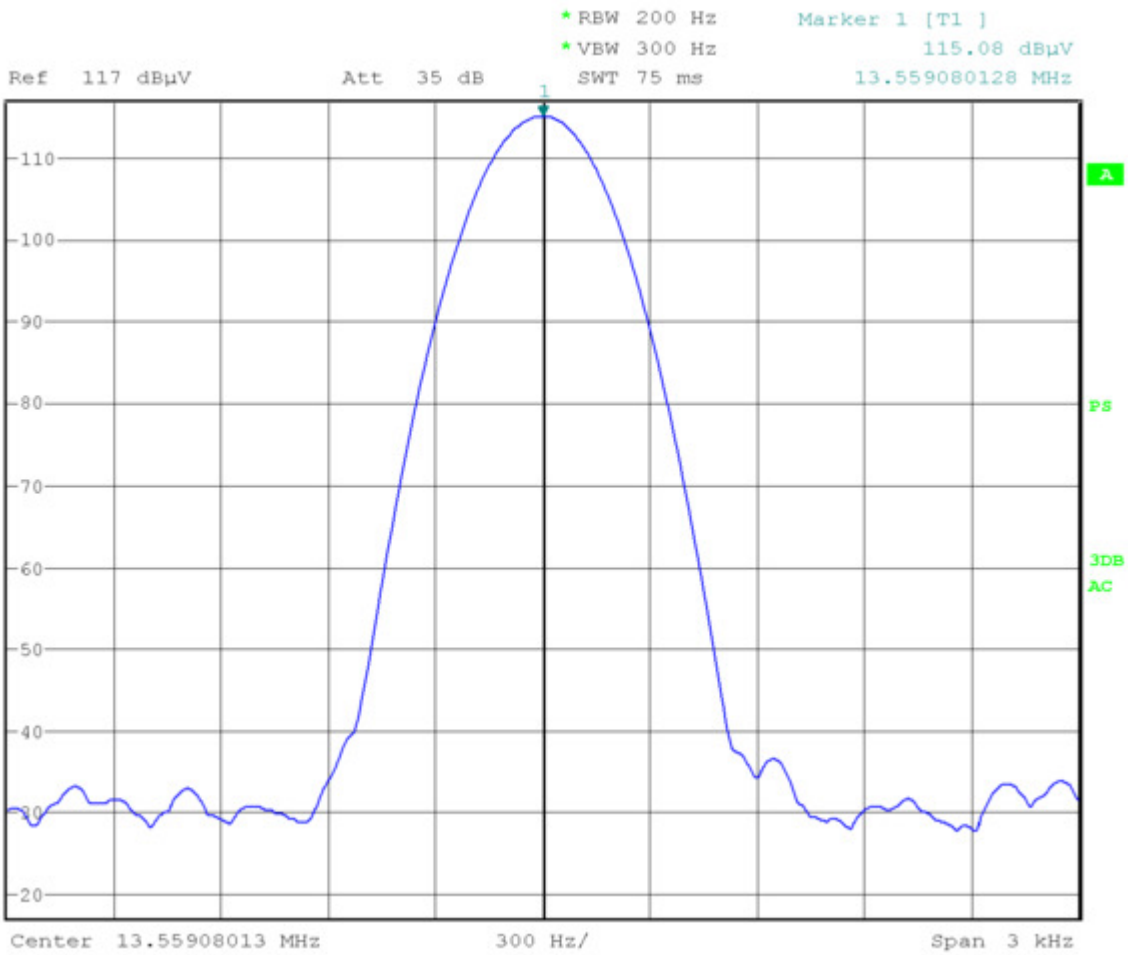


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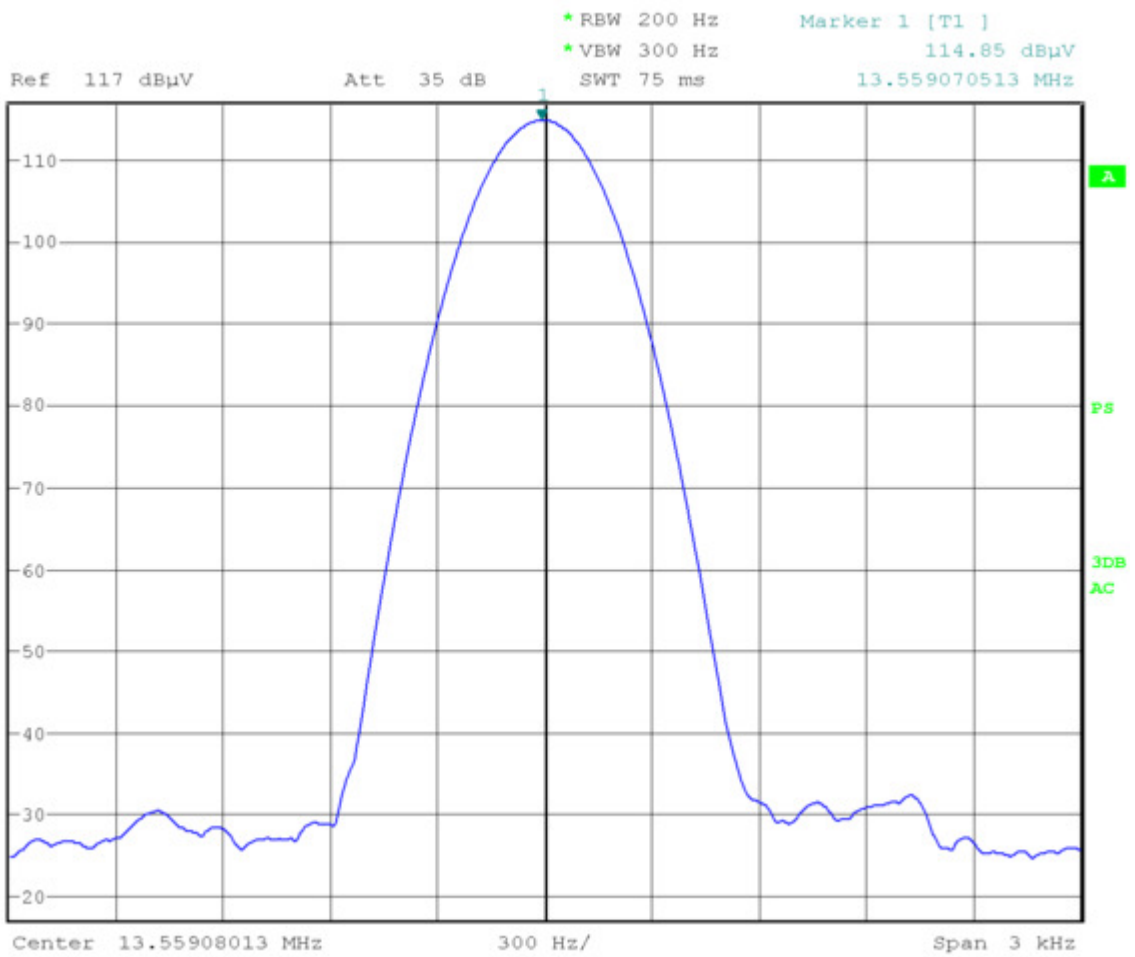


Picture 28: +30°C, 5 VDC



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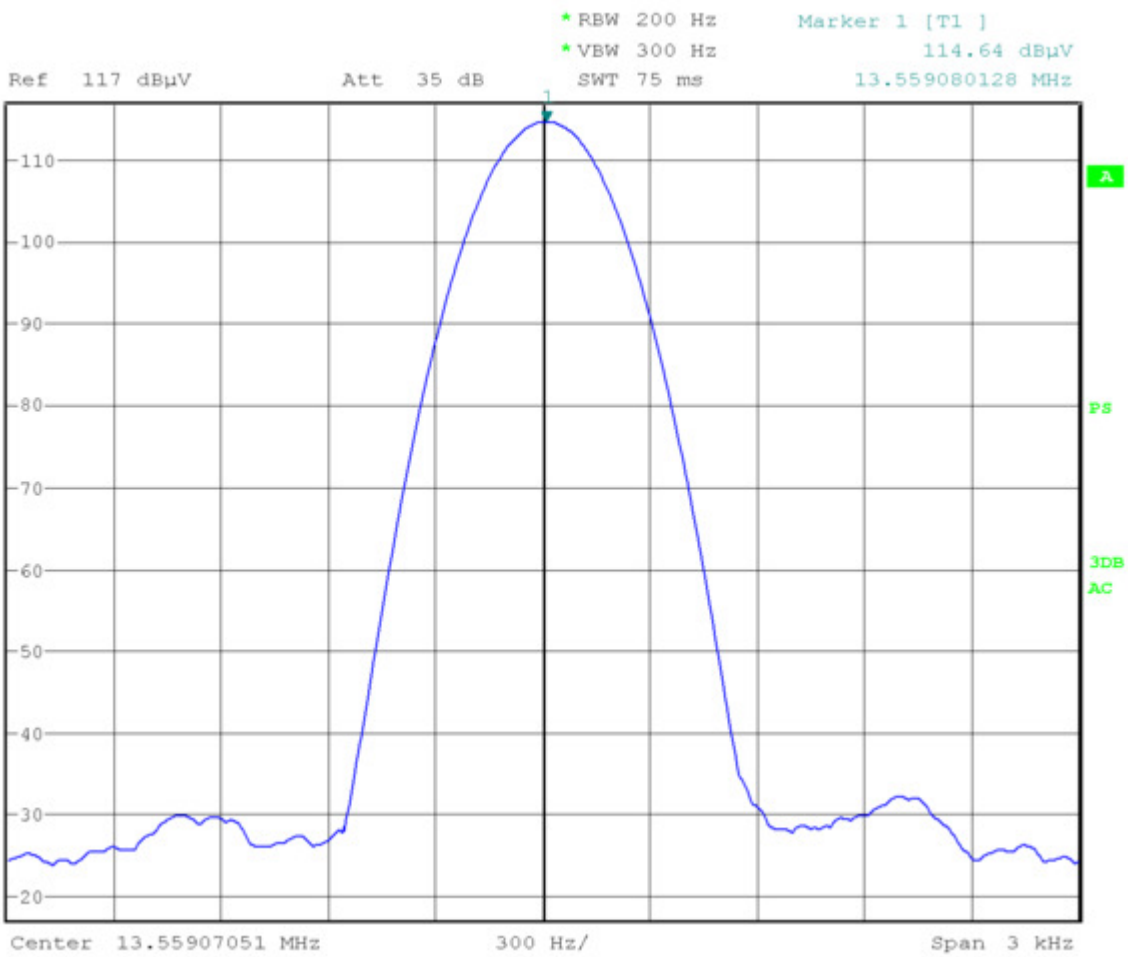
Picture 29: +40°C, 5 VDC



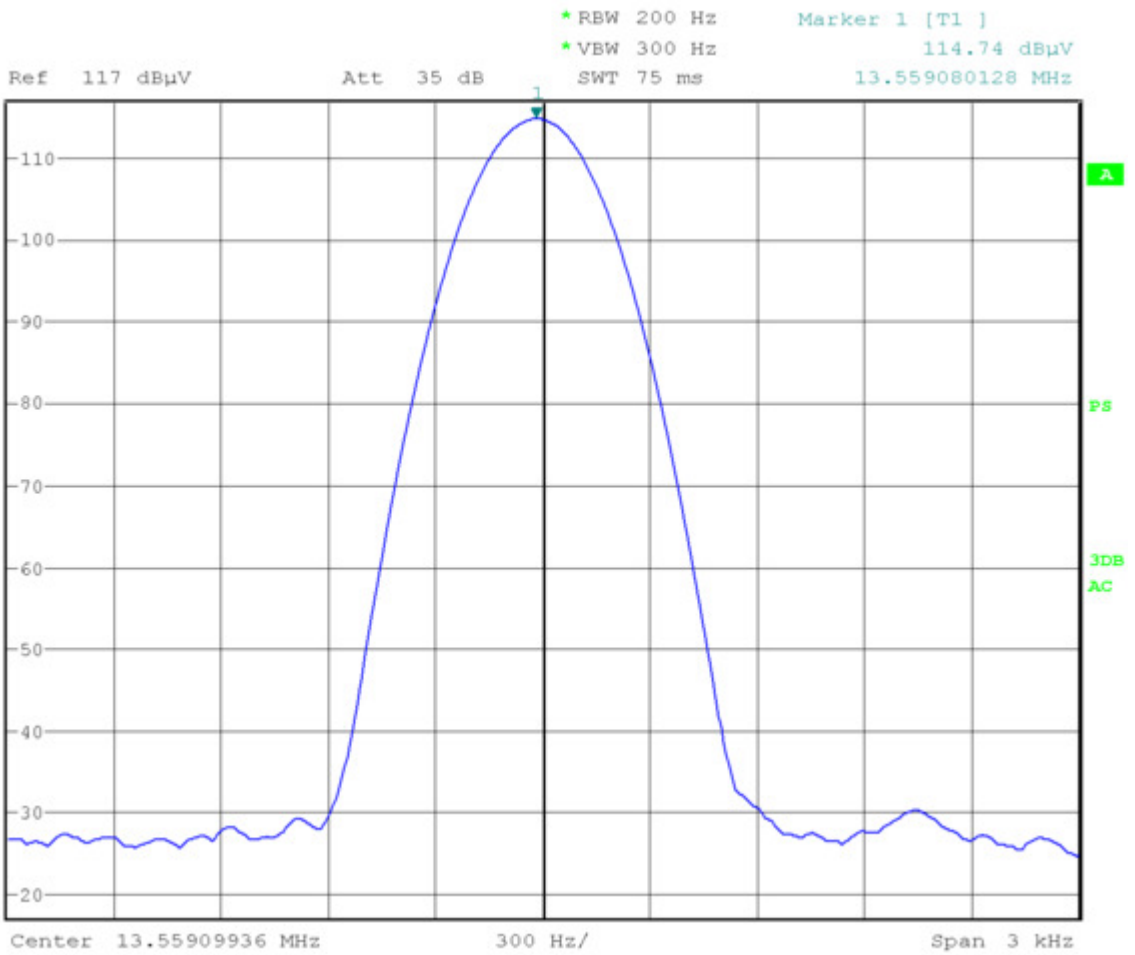
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Picture 30: +50°C, 5 VDC

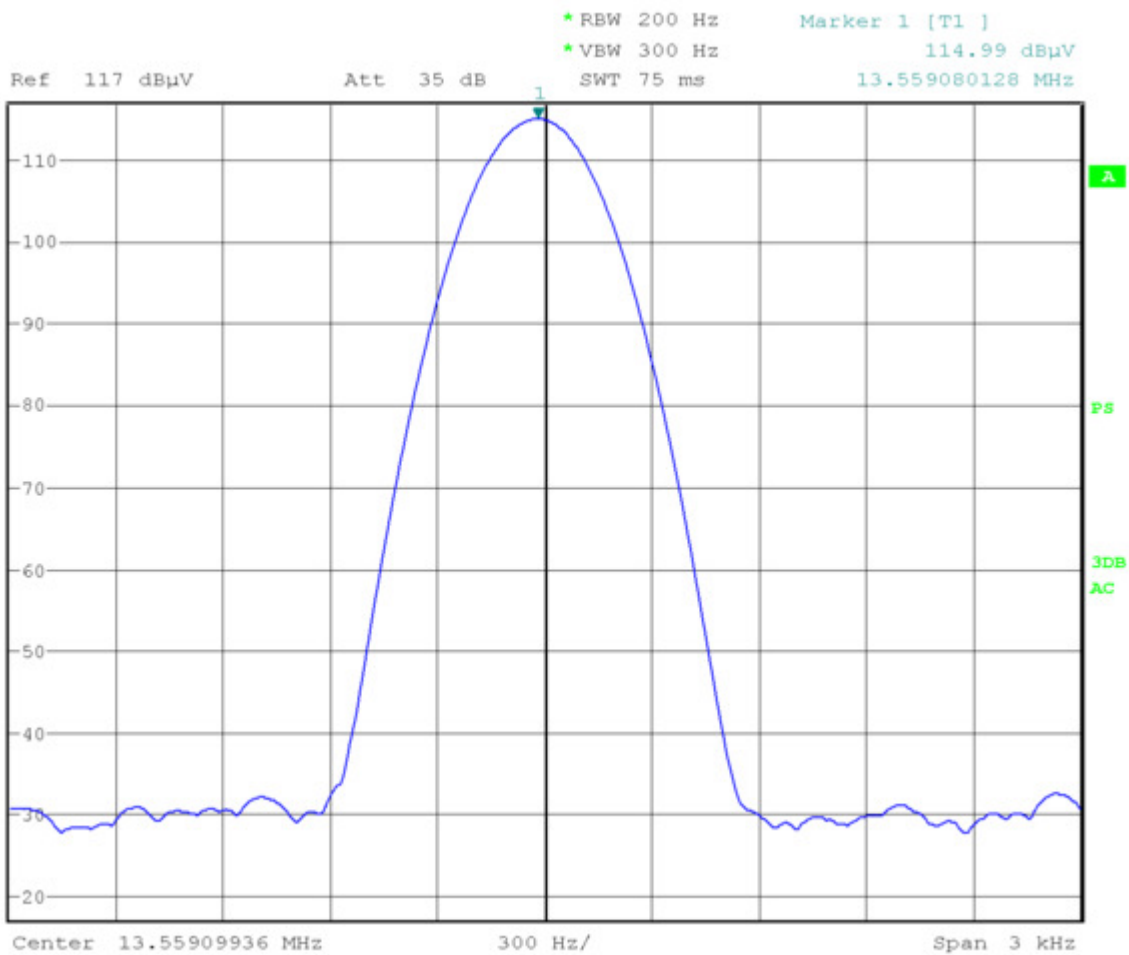


Picture 31: 20°C, 4.25 VDC



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Picture 32: 20°C, 5.75 VDC



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# 10 Designation of Emissions

according to CFR 47 Part 2, Sections 2.201 and 2.202

## 10.1 Designation

Type of Modulation: Amplitude Modulation

Necessary Bandwidth:  $B_n = 2 \cdot B \cdot K$

Modulation Rate:  $B = 5kHz$

Overall numerical Factor:  $K = 1$

$$B_n = 2 \cdot 5kHz \cdot 1 = 10kHz$$

Designation of Emissions according ITU-R: **10K0A1D**

Comments:



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# 11 Equipment Calibration Status

Inventory Number	Model Number	Manufacturer	Last calibration	Next calibration	Cycle of calibration
100132	ESCI	Rohde & Schwarz	June 07	June 09	2 Years
100005	HFH2-Z2	Rohde & Schwarz	July 07	July 09	2 Years
100002	ESH 3	Rohde & Schwarz	Oct. 08	Oct. 09	1 Year
200051	ESH3 Z2	Rohde & Schwarz	Oct. 08	Oct. 09	1 Year
100040	ESH 2-Z5	Rohde & Schwarz	Oct. 07	Oct. 09	2 Years
100041	ESH 2-Z5	Rohde & Schwarz	Aug. 08	Aug. 10	2 Years
100072	ESCS 30	Rohde & Schwarz	July 08	July 09	1 Year
100077	VULB 9163	Schwarzbeck	April 08	April 10	2 Years
100064	VULB 9160	Schwarzbeck	March 07	March 09	2 Years
110040	VC <sup>3</sup> 4034	Vötsch	June 08	June 10	2 Years
110023	VC4100	Vötsch	January 07	January 09	2 Years
100080	Multimeter	Metra Hit 29S	May 08	May 09	1 Year

**Table 4: Equipment Calibration status**



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## 12 Summary

The EMC Regulations according to the marked specifications are

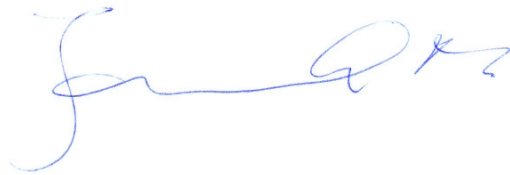
**KEPT**

The EUT does fulfill the general approval requirements mentioned.

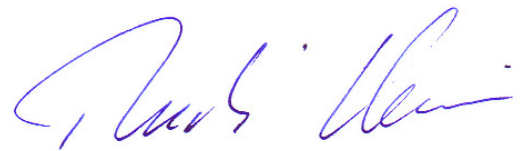
**NOT KEPT**

The EUT does not fulfill the general approval requirements mentioned.

Place, Date: Straubing, May 20, 2009



Marco Janker  
EMI / EMC Test Engineer



Rudolf Klein  
GM / EMV **TESTHAUS** GmbH



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